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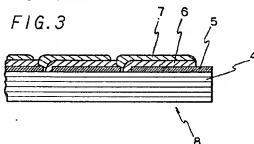
(54) Method for forming a thin film pattern.

(57) A method for forming a thin film pattern comprising the steps in sequence of forming a lift-off layer (2) directly on a substrate (1) wherein a pattern of the lift-off layer is reverse to a desired thin film pattern, forming a thin film (3) on the substrate, removing an undesirable portion of the thin film (3) together with the lift-off layer (2); and a method for producing a semiconductor device (8) comprising the steps in sequence of forming a first electrode (5) on an insulated substrate (4), removing a part of the first electrode (5), forming a semiconductor including amorphous material (6) on the first electrode (5), forming a lift-off layer on the semiconductor including amorphous material at such a place whereon a second electrode is not desired to be formed,

and forming a second electrode (7) on the semiconductor.

According to the present invention, a thin film pattern can be formed at low production cost, with high productivity and accuracy, and with less danger during the process.

FIG. 3





DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. Cl. 4)
X	DE-A-2 420 394 (CANON K.K.) * Page 5, last paragraph - page 14, paragraph 1; claims; figures * ---	1,2,4 6,13, 14,17	H 01 L 31/18 H 01 L 31/02 H 01 L 21/00
X	US-A-4 489 101 (ULSI TECHNOLOGY RESEARCH) * Column 3, line 17 - column 4, line 66; claims; figures * ---	1,6,8, 14	
X	US-A-4 218 532 (BELL TELEPHONE LABORATORIES) * Claims; figures 1-8 * ---	1,6,10 ,13,14 ,17	
X	US-A-4 497 684 (AMDAHL CORP.) * Claims; figures * ---	1,6,18 ,13,14 ,17	TECHNICAL FIELDS SEARCHED (Int. Cl. 4) H 01 L
E	EP-A-0 178 327 (NISSHA PRINTING CO.) * Page 6, paragraph 1 - page 16, paragraph 1; claims; figures * -----	1,2,5, 6,13, 14,17	
The present search report has been drawn up for all claims			
Place of search THE HAGUE		Date of completion of the search 16-10-1987	Examiner GORUN M.
CATEGORY OF CITED DOCUMENTS		T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons A : technological background O : non-written disclosure P : intermediate document	
X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document			